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(54) OPERATIONAL AMPLIFIER AND METHOD OF OPERATING THE OPERATIONAL AMPLIFIER

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See application file for complete search history.

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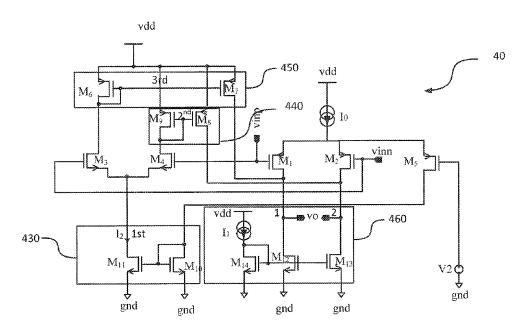
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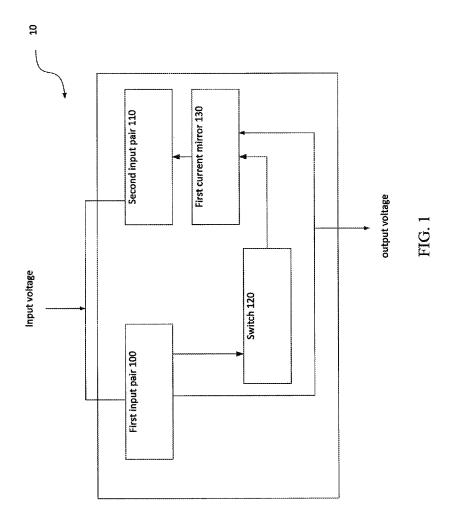
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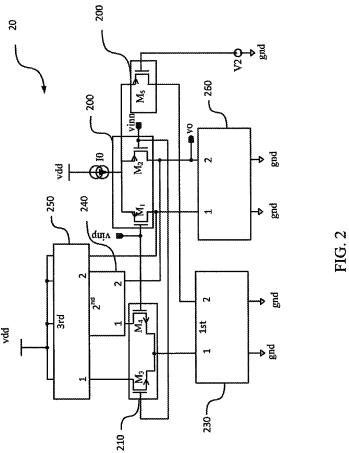
(57) ABSTRACT

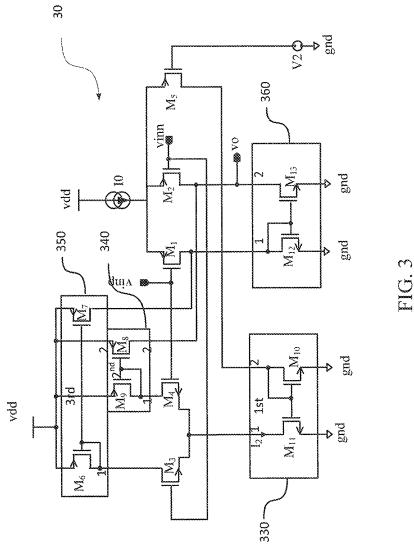
An operational amplifier comprises a first input pair, a second input pair, a switch and a first current mirror. The first input pair comprises a different type of MOS transistor from the second input pair. The switch determines which one of the first or the second input pair is functioning and the operating input pair is configured to output voltage. The switch is further connected to the first input pair and the first current mirror. The first current mirror is further connected to the second input pair, and is configured to copy a current passing through the switch to the second input pair. Therefore an increase of transconductance of the first input pair is compensated by a decrease of transconductance of the second input pair, and the operational amplifier has a substantially constant transconductance no matter which of the first input pair and the second input pair is functioning.

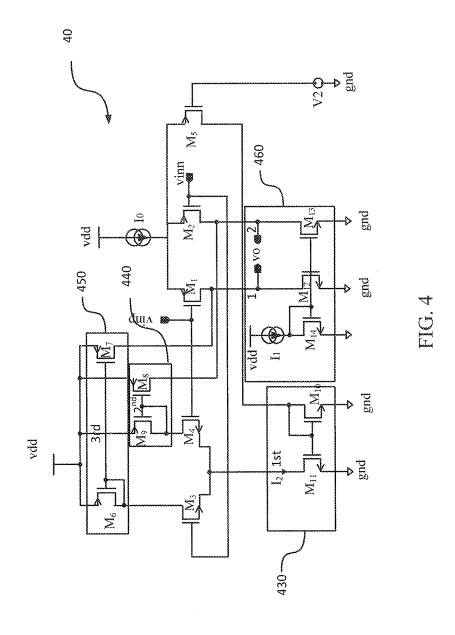
16 Claims, 6 Drawing Sheets

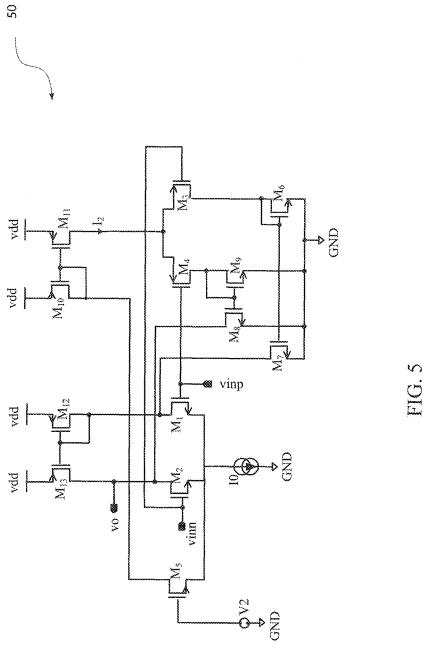


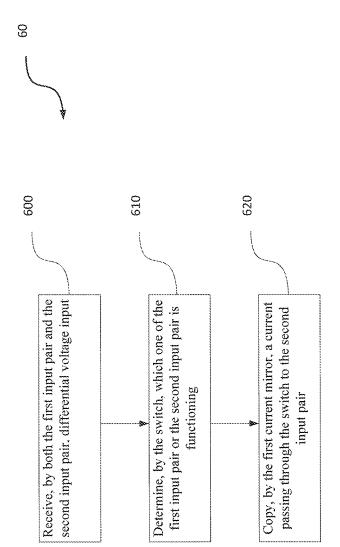












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OPERATIONAL AMPLIFIER AND METHOD OF OPERATING THE OPERATIONAL AMPLIFIER

CLAIM OF PRIORITY

This application claims priority to Chinese Application No. 201410723184.4 entitled "Operational amplifier and method of operating the operational amplifier," filed on Dec. 2, 2014 by Beken Corporation, which is incorporated herein by reference.

TECHNICAL FIELD

The present application relates to circuits, and more ¹⁵ particularly but not exclusively to an operational amplifier and method of operating the operational amplifier.

BACKGROUND

Conventional operational amplifiers use both a PMOS transistor pair and a NMOS transistor pair to alternate functioning so as to ensure that the operational amplifier can be operating when the input signal ranges from ground to the positive power supply (vdd). However, there are cases when 25 both the PMOS transistor pair and the NMOS transistor are functioning, or neither the PMOS transistor pair nor the NMOS transistor pair is functioning, which means a changing transconductance of the operational amplifier and resulting in a distortion of output signal. Therefore, it is desirable 30 to design an operational amplifier with substantially constant transconductance.

SUMMARY OF THE INVENTION

In an embodiment, an operational amplifier comprises a first input pair, a second input pair, a switch and a first current mirror, wherein the first input pair comprises a different type of MOS transistor from the second input pair; the switch is configured to determine which one of the first input pair or the second input pair is functioning, wherein the switch is further connected to the first input pair and the first current mirror, and the operating input pair is configured to output voltage; and the first current mirror is further connected to the second input pair, and is configured to copy 45 a current passing through the switch to the second input pair, such that the operational amplifier has a substantially constant transconductance no matter which of the first input pair and the second input pair is functioning.

Another embodiment discloses a method in an operational 50 amplifier. The operational amplifier comprises a first MOS transistor, a second MOS transistor, a third MOS transistor, a fourth MOS transistor and a fifth MOS transistor, a third current mirror, a second current mirror, a first current mirror and a load unit, wherein first nodes of the first and second 55 MOS transistors are both connected to both a first current source and a first node of the fifth MOS transistor; a second node of the first MOS transistor is connected to a second node of the fourth MOS transistor, a third node of the first transistor is connected to both a second port of the third 60 current mirror and a first port of the load unit; a second node of the second MOS transistor is connected to a second node of the third MOS transistor, a third node of the second transistor is connected to both a second port of the second current mirror and a second node of the load unit. First nodes 65 of both the third and fourth MOS transistors are connected to a first port of the first current mirror, a third node of the

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third MOS transistor is connected to a first port of the third current mirror, a third node of the fourth MOS transistor is connected to a first port of the second current mirror; a second node of the fifth MOS transistor is connected to a voltage source, a third node of the fifth MOS transistor is connected to a second port of the first current mirror. The method comprises receiving, at the second node of the first MOS transistor, a positive input; receiving, at the second node of the second MOS transistor, a negative input; and outputting an output voltage at the third node of the second MOS transistor.

BRIEF DESCRIPTION OF THE DRAWINGS

Non-limiting and non-exhaustive embodiments of the present invention are described with reference to the following figures, wherein like reference numerals refer to like parts throughout the various views unless otherwise specified.

FIG. 1 is a diagram illustrating an embodiment of an operational amplifier.

FIG. 2 is a diagram illustrating another embodiment of an operational amplifier.

FIG. 3 is a diagram illustrating a specific implementation of the operational amplifier shown in FIG. 2.

FIG. 4 is a diagram illustrating another specific implementation of the operational amplifier shown in FIG. 2.

FIG. 5 is a diagram illustrating another specific implementation of the operational amplifier shown in FIG. 2.

FIG. 6 is a flow chart of a method of operating the operational amplifier.

DETAILED DESCRIPTION OF THE ILLUSTRATED EMBODIMENTS

Various aspects and examples of the invention will now be described. The following description provides specific details for a thorough understanding and enabling description of these examples. Those skilled in the art will understand, however, that the invention may be practiced without many of these details. Additionally, some well-known structures or functions may not be shown or described in detail, so as to avoid unnecessarily obscuring the relevant description

FIG. 1 is a diagram illustrating an embodiment of an operational amplifier. The operational amplifier 10 comprises a first input pair 100, a second input pair 110, a switch 120 and a first current mirror 130. The first input pair 100 comprises a MOS transistor different from that of the second input pair 110. For example, when the first input pair 110 comprises PMOS transistors, then the second input pair 1.20 comprises NMOS transistors. When the first input pair 110 comprises NMOS transistors, then the second input pair 120 comprises PMOS transistors. The switch 120 is configured to determine which one of the first input pair 100 or the second input pair 110 is functioning. The switch 120 is further connected to the first input pair 100 and the first current mirror 130. The input pair functioning, is configured to output voltage. For example, if the switch 120 determines that the first input pair 100 is functioning, then the first input pair 100 outputs voltage. If the switch 120 determines that the second input pair 110 is functioning, then the second input pair 110 outputs voltage. The first current mirror 130 is further connected to the second input pair 110, and is configured to copy a current passing through the switch 120 to the second input pair 110, such that the operational

amplifier 10 has a substantially constant transconductance no matter which of the first input pair 100 and the second input pair 110 is functioning.

Alternatively, at least one of the first input pair 100 and the second input pair 110 is configured to be functioning during the operation range of the operational amplifier 10.

FIG. 2 is a diagram illustrating another embodiment of an operational amplifier 20. The operational amplifier 20 also comprises a first input pair 200, a second input pair 210, a switch 220 and a first current mirror 230. To be more 10 specific, the first input pair 200 comprises a first MOS transistor M_1 and a second MOS transistor M_2 . The second input pair 210 comprises a third MOS transistor M_3 and a fourth MOS transistor M_4 . The switch 200 comprises a fifth MOS M_5 . The operational amplifier further comprises a 15 second current mirror 240, a third current mirror 250 and a load unit 260.

Any two of a first node of the first MOS transistor M₁, a first node of the second MOS transistor M₂, a first current source to and a first node of the fifth MOS transistor M5 are 20 connected. A second node of the first MOS transistor M₁ is connected to a second node of the fourth MOS transistor M₄ and the second node of the first MOS transistor M₁ is also configured to receive a positive input vine. A third node of the first transistor M_1 is connected to both a second port of 25 the third current mirror 250 and a first port of the load unit **260.** A second node of the second MOS transistor M_2 is connected to a second node of the third MOS transistor M₃ and the second node of the second MOS transistor M2 is also configured to receive a negative input vinn. A third node of 30 the second transistor M₂ is connected to both a second port of the second current mirror 240 and a second node of the load unit 260 and the third node of the second transistor M, is also configured to output voltage.

First nodes of both the third and fourth MOS transistors M_3 , M_4 are connected to a first port of the first current mirror **230**. A third node of the third MOS transistor M_3 is connected to a first port of the third current mirror **250**. A third node of the fourth MOS transistor M_4 is connected to a first port of the second current mirror **240**.

A second node of the fifth MOS transistor M_5 is connected to a voltage source V2, and the voltage source V2 is connected to ground. A third node of the fifth MOS transistor M_5 is connected to a second port of the first current mirror 230.

The first node of the first current mirror 230 has a current that mirrors the second node of the first current mirror 230. The first node of the second current mirror 240 has a current that mirrors the second node of the second current mirror 240. The third node of the first current mirror 240 has a 50 current that mirrors the second node of the third current mirror 240.

FIG. 3 is a diagram illustrating a specific implementation of the operational amplifier 30 shown in FIG. 2, The operational amplifier 30 comprises a first MOS transistor 55 M_1 , a second MOS transistor M_2 , a third MOS transistor M_3 , a fourth MOS transistor M_4 and a fifth MOS transistor M_5 , a first current mirror 330, a second current mirror 340, a third current mirror 350 and a load unit 360. The connection relationship among these elements are similar to that of FIG. 60 2, and details are omitted for elements already described with respect to FIG. 2.

As shown in FIG. 3, the third current mirror 350 comprises a sixth MOS transistor M_6 and a seventh MOS transistor M_7 . First nodes of both the sixth and the seventh MOS transistors M_6 , M_7 are connected to a first power source. Both second and third nodes of the sixth MOS

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transistor M_6 are connected to both a second node of the seventh MOS transistor M_7 and the third node of the third MOS transistor M_3 . The first port of the third current mirror **350** comprises the third node of the sixth MOS transistor M_6 . The second port of the third current mirror **350** comprises a third node of the seventh MOS transistor M_7 .

Alternatively, the second current mirror 340 comprises an eighth MOS transistor M_8 and a ninth MOS transistor M_9 . First nodes of both the eighth and the ninth MOS transistors M_8 and M_9 are connected to the first power source. Both second and third nodes of the ninth MOS transistor M_9 are connected to a second node of the eighth MOS transistor M_8 and the third node of the fourth MOS transistor M_4 . The first port of the second current mirror 340 comprises the third node of the ninth MOS transistor M_9 , and the second port of the second current mirror 340 comprises a third node of the eighth MOS transistor M_8 .

The first current mirror **330** comprises a tenth MOS transistor M_{10} and an eleventh MOS transistor M_{11} . First nodes of both the tenth and the eleventh MOS transistors M_{10} and M_{11} are connected to the second power source. Both second and third nodes of the tenth MOS transistor M_{10} are connected to both a second node of the eleventh MOS transistor M_{11} and the third node of the fifth MOS transistor M_{5} . The first port of the first current mirror **330** comprises a third node of the eleventh MOS transistor M_{11} . The second port of the first current mirror **330** comprises the third node of the tenth MOS transistor M_{10} .

Alternatively, the load unit **360** comprises a twelfth MOS transistor M_{12} and a thirteenth MOS transistor M_{13} . First nodes of both the twelfth MOS transistor M_{12} and the thirteenth MOS transistor M_{13} are connected to the second power source. A second node and a third node of the twelfth MOS transistor M_{12} are both connected to a second node of the thirteenth MOS transistor M_{13} . A third node of the twelfth MOS transistor M_{13} comprises the first node of the load unit **360**. A third node of the thirteenth MOS M_{13} comprises the second node of the load unit **360**.

As shown in FIG. 3, the first, the second, the fifth, the sixth, the seventh, the eighth and the ninth MOS transistors M_1 , M_2 , M_5 , M_6 , M_7 , M_8 and M_9 are PMOS transistors. The third, the fourth, the tenth, and the eleventh MOS transistors M_3 , M_4 , M_{10} , M_{11} , M_{12} , and M_{13} are NMOS transistors.

The first node of each of the transistors is a source, the second node of each of the transistors is a gate, and the third node of each of the transistors is a drain. The first power source comprises a positive power source Vdd, and the second power source comprises ground (gnd).

Referring to FIG. 3, during operation, when vinp=vinn>V2, the PMOS transistors M₁ and M₂, which includes the first input pair, are off, and the switch 200, which for example, includes the fifth PMOS transistor M₅ is on. The current that passes through the fifth PMOS transistor M_5 is copied by the current mirror 330 to the second input pair, represented as current I2, therefore the second input pair, which for example, includes the third NMOS transistor M_3 and the fourth NMOS transistor M_4 , is on. The current I₂ works as a current sink for the third NMOS transistor M₃ and the fourth NMOS transistor M_4 . On the other hand, when vinp=vinn \leq V2, the PMOS transistors M_1 and M_2 , which includes the first input pair, are on, and the switch 200, which for example, includes the fifth PMOS transistor M₅, is off No current passes through the fifth PMOS transistor M₅. As a result, no current is copied by the current mirror 330 to the second input pair, which for example, includes the third NMOS transistor M3 and the fourth NMOS transistor M₄. Therefore the second input pair is off.

As the operational amplifier with the input pairs is functioning when an input signal varies from almost ground to vdd, the operational amplifier is also called rail-to-rail operational amplifier. Further, as normally only one input pair works during the overall operation range of the operational amplifier, the manufacture parameters can be selected so that the NMOS input pair matches the PMOS input pair, and the operational amplifier may have a substantially constant transconductance no matter which one of the NMOS input pair or the PMOS input pair works.

Even if both NMOS input pair and the PMOS input pair work simultaneously in some circumstances, as the first input pair comprises PMOS transistors, the second input pair comprises NMOS transistors, the variation of current that passes through the PMOS input pair is opposite to the 15 variation of current that passes through the NMOS input pair, therefore the substantially constant transconductance can be easily obtained.

In an embodiment, as $\rm M_5$ operates as common mode circuit to the differential input, the PMOS transistor $\rm M_5$ does 20 not generate differential noise to the circuit with differential input, and the circuit will not generate extra noise. Further, the circuit eliminates dead zone as only one device $\rm M_5$ is used to control whether PMOS pair or NMOS pair works. Dead zone means neither the PMOS input pair, nor the 25 NMOS input pair is on.

FIG. 4 is a diagram illustrating another specific implementation of the operational amplifier 40 shown in FIG. 2. As other components such as first current mirror 430, second current mirror 440 and third current mirror 450 except the 30 loading unit 460 in the operational amplifier 40 are similar to that shown in FIG. 3, details are omitted for elements already described with respect to FIG. 2 and FIG. 3. Alternatively, the load unit 460 comprises a twelfth MOS transistor M₁₂, a thirteenth MOS transistor M₁₃, a fourteenth 35 MOS transistor M_{14} and a second current source I_1 . The first nodes of all the twelfth MOS transistor M_{12} , the thirteenth MOS M₁₃ transistor and the fourteenth MOS transistor M₁₄ are connected to the second power source. A second node of the twelfth MOS transistor M₁₂ is connected to second nodes 40 of both the thirteenth MOS transistor M₁₃ and the fourteenth MOS transistor M_{14} . The second node of the fourteenth MOS transistor M₁₄ is also connected to both a third node of the fourteenth MOS transistor M₁₄ and the second current source I_1 . A third node of the twelfth MOS transistor M_{12} 45 comprises the first node of the load unit 460 and a third node of the thirteenth MOS transistor M₁₃ comprises the second node of the load unit 460. The first node and the second node of the load unit 460 are configured to output differential output voltage vo.

FIG. **5** is a diagram illustrating another specific implementation of the operational amplifier **50** shown in FIG. **2**. As shown in the operational amplifier **50** in FIG. **5**, the first, the second, the fifth, the sixth, the seventh, the eighth and the ninth MOS transistors M₁, M₂, M₅, M₆, M₇, M₈ and M₉ are 55 NMOS transistors. The third, the fourth, the tenth, and the eleventh, the twelfth and the thirteenth MOS transistors M₃, M₄, M₁₀, M₁₁, M₁₂, M₁₃ are PMOS transistors. The first node of each of the transistors is a source, the second node of each of the transistors is a gate, and the third node of each of the transistors is a drain. The first power source comprises a ground. GND, and the second power source comprises a positive power supply Vdd. The voltage source V**2** is connected to ground.

Referring to FIG. 5, during operation, when 65 vinp=vinn>V2, the NMOS transistors M_1 and M_2 , which comprise the second input pair, are on, and the fifth NMOS

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transistor M_5 is off. No current passes through the fifth NMOS transistor M_5 . As a result, no current is copied by the first current mirror, which comprises the tenth PMOS transistor M_{10} and the eleventh PMOS transistor M_{11} , to the third PMOS transistor M_3 and the fourth PMOS transistor M_4 , which comprise the second input pair. Therefore the second input pair is off. When vinp=vinn<V2, the NMOS transistors M_1 and M_2 , which includes the first input pair, are off, and the fifth NMOS transistor M_5 is on. The current that passes through the fifth NMOS transistor M_5 is copied by the first current mirror to the second input pair, which for example, includes the third PMOS transistor M_3 and the fourth PMOS transistor M_4 , therefore the second input pair is on. The current I_2 works as a current source for the third PMOS transistor M_4 .

As the operational amplifier with the input pairs is functioning during the whole range that an input signal that varies from almost ground to vdd, the operational amplifier is also called rail-to-rail operational amplifier. Further, as normally only one input pair works during the overall operation range of the operational amplifier, the manufacture parameters can be selected so that the NMOS input pair matches the PMOS input pair, and the operational amplifier may have a substantially constant transconductance no matter which one of the NMOS input pair or the PMOS input pair works.

Even if both NMOS input pair and the PMOS input pair work simultaneously in some circumstances, as the first input pair comprises NMOS transistors, the second input pair comprises PMOS transistors, the variation of current that passes through the first input pair is opposite to the variation of current that passes through the second input pair, therefore the substantially constant transconductance can be easily obtained.

In an embodiment, as M_5 operates as common mode circuit to the differential input, the NMOS transistor M_5 does not generate differential noise to the circuit with differential input, the circuit will not generate extra noise. As the circuit will not generate extra noise, the circuit will not consume extra current, which is advantageous for reducing power consumption and reducing noise. Further, the circuit eliminates dead zone as only one device M_5 is used to control whether PMOS pair or NMOS pair works. Dead zone means neither the PMOS input pair, nor the NMOS input pair is on.

FIG. 6 is flow chart of a method 60 of operating the operational amplifier. The method 60 operates in an operational amplifier. Referring back to FIG. 1, the operational amplifier comprises a first input pair 100, a second input pair 110, a switch 120 and a first current mirror 130. The first input pair 110 comprises a different type of MOS transistor from the second input pair 110, For example, when the first input pair 110 comprises PMOS transistor, then the second input pair 120 comprises NMOS transistor. When the first input pair 110 comprises NMOS transistor, then the second input pair 120 comprises PMOS transistor. The switch 120is configured to determine which one of the first input pair 100 or the second input pair 110 is functioning. The switch 120 is further connected to the first input pair 100 and the first current mirror 130. The input pair functioning is configured to output voltage. For example, if the switch 120 determines that the first input pair 100 is functioning, then the first input pair 100 outputs voltage. if the switch 120 determines that the second input pair 110 is functioning, then the second input pair 110 outputs voltage. The first current mirror 130 is further connected to the second input pair 110, and is configured to copy a current passing through the switch 120 to the second input pair 110 such that the

operational amplifier 10 has a substantially constant transconductance no matter which of the first input pair 100 and the second input pair 110 is functioning.

The method **60** comprises receiving (in block **600**), by both the first input pair and the second input pair, differential 5 voltage input; determining (in block **610**), by the switch, which one of the first input pair or the second input pair is functioning; copying (in block **620**), by the first current mirror, a current passing through the switch to the second input pair, such that the operational amplifier has a substantially constant transconductance, no matter which of the first input pair and the second input pair is functioning, In an alternative embodiment, when the first input pair and the second input pair are functioning simultaneously, an increase of transconductance of the first input pair is compensated by a decrease of transconductance of the second input pair.

In an embodiment, the determining (in block **610**) may be performed as follows: in case that transistors M_1 , M_2 and M_5 are NMOS transistors, and M_3 and M_4 are PMOS transistors as shown in FIG. **5**, if vinp=vinn>V**2**, the NMOS transistors M_1 and M_2 are on, and the fifth NMOS transistor M_5 is off, then the fifth PMOS transistor M**5** determines M_1 and M_2 are on, and M_3 and M**4** are off. If vinp=vinn<V**2**, the NMOS transistors M_1 and M_2 are off, and the fifth NMOS transistor M_3 is on, then M_5 determines M_1 and M_2 are off, and M_3 and M_4 are on.

In another embodiment, the determining (in block **610**) may be performed as follows: in case that transistors M_1 , M_2 and M_5 are PMOS transistors, and M_3 and M_4 are NMOS 30 transistors as shown in FIG. **2**, if vinp=vinn>V**2**, the PMOS transistors M_1 and M_2 are off, and the fifth PMOS transistor M_5 is on, then the fifth PMOS transistors M_3 and M_4 are on. If vinp=vinn<V**2**, the PMOS transistors M_1 and M_2 are off, and transistors M_1 and M_2 are on, and the fifth PMOS transistor M_5 is off, then the transistor M_5 determines transistors M_1 and M_2 are on, and transistors M_3 and M_4 are off.

It should be appreciated by those ordinary skill in the art that components from different embodiments may be combined to yield another technical solution. This written description uses examples to disclose the invention, including the best mode, and also to enable any person ordinary skill in the art to practice the invention, including making and using any devices or systems and performing any 45 incorporated methods. The patentable scope of the invention is defined by the claims, and may include other examples that occur to those ordinary skill in the art. Such other examples are intended to be within the scope of the claims if they have structural elements that do not differ from the 50 literal language of the claims, or if they include equivalent structural elements with insubstantial differences from the literal languages of the claims.

What is claimed is:

1. An operational amplifier comprising a first input pair, 55 a second input pair, a switch and a first current mirror,

wherein the first input pair comprises a different type of MOS transistor from the second input pair;

the switch is configured to determine which one of the first input pair or the second input pair is functioning, 60 wherein the switch is further connected to the first input pair and the first current mirror, and the input pair functioning is configured to output voltage; and

the first current mirror is further connected to the second input pair, and is configured to copy a current passing 65 through the switch to the second input pair, such that the operational amplifier has a substantially constant 8

transconductance no matter which of the first input pair and the second input pair is functioning,

wherein the first input pair comprises a first MOS transistor and a second MOS transistor, the second input pair comprises a third MOS transistor and a fourth MOS transistor, the switch comprises a fifth MOS, and the operational amplifier further comprises a second current mirror, a third current mirror and a load unit;

wherein any two of a first node of the first MOS transistor, a first node of the second MOS transistor, a first current source and a first node of the fifth MOS transistor are connected; a second node of the first MOS transistor is connected to a second node of the fourth MOS transistor and is also configured to receive a positive input, a third node of the first transistor is connected to both a second port of the third current mirror and a first port of the load unit; a second node of the second MOS transistor is connected to a second node of the third MOS transistor and is also configured to receive a negative input, a third node of the second transistor is connected to both a second port of the second current mirror and a second node of the load unit and is also configured to output voltage;

first nodes of both the third and fourth MOS transistors are connected to a first port of the first current mirror, a third node of the third MOS transistor is connected to a first port of the third current mirror, a third node of the fourth MOS transistor is connected to a first port of the second current mirror;

a second node of the fifth MOS transistor is connected to a voltage source, a third node of the fifth MOS transistor is connected to a second port of the first current mirror, wherein

the third current mirror comprises a sixth MOS transistor and a seventh MOS transistor, first nodes of both the sixth and the seventh MOS transistors are connected to a first power source, both second and third nodes of the sixth MOS transistor are connected to both a second node of the seventh MOS transistor and the third node of the third MOS transistor, and the first port of the third current mirror comprises the third node of the sixth MOS transistor, and the second port of the third current mirror comprises a third node of the seventh MOS transistor:

the second current mirror comprises an eighth MOS transistor and a ninth MOS transistor, first nodes of both the eighth and the ninth MOS transistors are connected to the first power source, both second and third nodes of the ninth MOS transistor are connected to a second node of the eighth MOS transistor and the third node of the fourth MOS transistor, and the first port of the second current mirror comprises the third node of the ninth MOS transistor, and the second port of the second current mirror comprises a third node of the eighth MOS transistor; and

the first current mirror comprises a tenth MOS transistor and an eleventh MOS transistor, first nodes of both the tenth and the eleventh MOS transistors are connected to the second power source, both second and third nodes of the tenth MOS transistor are connected to both a second node of the eleventh MOS transistor and the third node of the fifth MOS transistor, and the first port of the first current mirror comprises a third node of the eleventh MOS transistor, and the second port of the first current mirror comprises the third node of the tenth MOS transistor.

- 2. The operational amplifier of claim 1, wherein at least one of the first input pair and the second input pair is configured to be functioning during the operation range of the operational amplifier.
- **3**. The operational amplifier of claim **1**, wherein the load 5 unit comprises a twelfth MOS transistor and a thirteenth MOS transistor;
 - wherein first nodes of both the twelfth MOS transistor and the thirteenth MOS transistor are connected to the second power source, a second node and a third node of the twelfth MOS transistor are both connected to a second node of the thirteenth MOS transistor, a third node of the twelfth MOS transistor comprises the first node of the load unit and a third node of the thirteenth MOS comprises the second node of the load unit.
- **4**. The operational amplifier of claim **1**, wherein the load unit comprises a twelfth MOS transistor, a thirteenth MOS transistor, a fourteenth MOS transistor and a second current source:
 - wherein first nodes of all the twelfth MOS transistor, the 20 thirteenth MOS transistor and the fourteenth MOS transistor are connected to the second power source, a second node of the twelfth MOS transistor is connected to second nodes of both the thirteenth MOS transistor and the fourteenth MOS transistor, the second node of 25 the fourteenth MOS transistor is also connected to both a third node of the fourteenth MOS transistor and the second current source, a third node of the twelfth MOS transistor comprises the first node of the load unit and a third node of the thirteenth MOS transistor comprises 30 the second node of the load unit, wherein the first node and the second node of the load unit are configured to output differential output voltage.
- **5**. The operational amplifier of claim **1**, wherein the first, the second, the fifth, the sixth, the seventh, the eighth and the 35 ninth MOS transistors are PMOS transistors, the third, the fourth, the tenth, and the eleventh MOS transistors are NMOS transistors; and
 - the first node of each of the transistors is a source, the second node of each of the transistors is a gate, and the 40 third node of each of the transistors is a drain, the first power source comprises a positive power source, and the second power source comprises ground.
- **6**. The operational amplifier of claim **3**, wherein the twelfth and the thirteenth MOS transistors are NMOS tran- 45 sistors, and
 - the first node of each of the twelfth and the thirteenth MOS transistors is a source, the second node of each of the twelfth and the thirteenth transistors is a gate, and the third node of each of the twelfth and the thirteenth 50 transistors is a drain.
- 7. The operational amplifier of claim 1, wherein the first, the second, the fifth, the sixth, the seventh, the eighth and the ninth MOS transistors are NMOS transistors, the third, the fourth, the tenth, and the eleventh MOS transistors are 55 PMOS transistors; and
 - the first node of each of the transistors is a source, the second node of each of the transistors is a gate, and the third node of each of the transistors is a drain, the first power source comprises a ground, and the second 60 power source comprises a positive power supply.
- **8**. The operational amplifier of claim **3**, wherein the twelfth and the thirteenth MOS transistors include PMOS transistors, and
 - the first node of each of the twelfth and the thirteenth 65 MOS transistors include a source, the second node of each of the twelfth and the thirteenth transistors include

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- a gate, and the third node of each of the twelfth and the thirteenth transistors include a drain.
- **9**. A method in an operational amplifier, wherein the operational amplifier comprises:
 - a first input pair, a second input pair, a switch and a first current mirror.
 - wherein the first input pair comprises a different type of MOS transistor from the second input pair;
 - the switch is connected to the first input pair and the first current mirror, and the input pair functioning is configured to output voltage; and
 - the first current mirror is further connected to the second input pair;

the method comprises:

- receiving, by both the first input pair and the second input pair, differential voltage input;
- determining, by the switch, which one of the first input pair or the second input pair is functioning;
- copying, by the first current mirror, a current passing through the switch to the second input pair, such that the operational amplifier has a substantially constant transconductance no matter which of the first input pair and the second input pair is functioning,
- wherein the first input pair comprises a first MOS transistor and a second MOS transistor, the second input pair comprises a third MOS transistor and a fourth MOS transistor, the switch comprises a fifth MOS, and the operational amplifier further comprises a second current mirror, a third current mirror and a load unit;
- wherein any two of a first node of the first MOS transistor, a first node of the second MOS transistor, a first current source and a first node of the fifth MOS transistor are connected; a second node of the first MOS transistor is connected to a second node of the fourth MOS transistor and is also configured to receive a positive input, a third node of the first transistor is connected to both a second port of the third current mirror and a first port of the load unit; a second node of the second MOS transistor is connected to a second node of the third MOS transistor and is also configured to receive a negative input, a third node of the second transistor is connected to both a second port of the second current mirror and a second node of the load unit and is also configured to output voltage;
- first nodes of both the third and fourth MOS transistors are connected to a first port of the first current mirror, a third node of the third MOS transistor is connected to a first port of the third current mirror, a third node of the fourth MOS transistor is connected to a first port of the second current mirror;
- a second node of the fifth MOS transistor is connected to a voltage source, a third node of the fifth MOS transistor is connected to a second port of the first current mirror, wherein
- the third current mirror comprises a sixth MOS transistor and a seventh MOS transistor, first nodes of both the sixth and the seventh MOS transistors are connected to a first power source, both second and third nodes of the sixth MOS transistor are connected to both a second node of the seventh MOS transistor and the third node of the third MOS transistor, and the first port of the third current mirror comprises the third node of the sixth MOS transistor, and the second port of the third current mirror comprises a third node of the seventh MOS transistor;

the second current mirror comprises an eighth MOS transistor and a ninth MOS transistor, first nodes of both the eighth and the ninth MOS transistors are connected to the first power source, both second and third nodes of the ninth MOS transistor are connected to a second node of the eighth MOS transistor and the third node of the fourth MOS transistor, and the first port of the second current mirror comprises the third node of the ninth MOS transistor, and the second port of the second current mirror comprises a third node of the eighth MOS transistor; and

the first current mirror comprises a tenth MOS transistor and an eleventh MOS transistor, first nodes of both the tenth and the eleventh MOS transistors are connected to the second power source, both second and third nodes of the tenth MOS transistor are connected to both a second node of the eleventh MOS transistor and the third node of the fifth MOS transistor, and the first port of the first current mirror comprises a third node of the eleventh MOS transistor, and the second port of the first current mirror comprises the third node of the tenth MOS transistor.

- 10. The method of claim 9, wherein an increase of transconductance of the first input pair is compensated by a decrease of transconductance of the second input pair.
- 11. The method of claim 9, wherein the load unit comprises a twelfth MOS transistor and a thirteenth MOS transistor;

wherein first nodes of both the twelfth MOS transistor and the thirteenth MOS transistor are connected to the second power source, a second node and a third node of the twelfth MOS transistor are both connected to a second node of the thirteenth MOS transistor, a third node of the twelfth MOS transistor comprises the first node of the load unit and a third node of the thirteenth MOS comprises the second node of the load unit.

12. The method of claim 9, wherein the load unit comprises a twelfth MOS transistor, a thirteenth MOS transistor, a fourteenth MOS transistor and a second current source;

wherein first nodes of all the twelfth MOS transistor, the 40 thirteenth MOS transistor and the fourteenth MOS transistor are connected to the second power source, a second node of the twelfth MOS transistor is connected to second nodes of both the thirteenth MOS transistor

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and the fourteenth MOS transistor, the second node of the fourteenth MOS transistor is also connected to both a third node of the fourteenth MOS transistor and the second current source, a third node of the twelfth MOS transistor comprises the first node of the load unit and a third node of the thirteenth MOS transistor comprises the second node of the load unit, wherein the first node and the second node of the load unit are configured to output differential output voltage.

13. The method of claim 9, wherein the first, the second, the fifth, the sixth, the seventh, the eighth and the ninth MOS transistors are PMOS transistors, the third, the fourth, the tenth, and the eleventh MOS transistors are NMOS transistors; and

the first node of each of the transistors is a source, the second node of each of the transistors is a gate, and the third node of each of the transistors is a drain, the first power source comprises a positive power source, and the second power source comprises ground.

14. The method of claim 11, wherein the twelfth and the thirteenth MOS transistors are NMOS transistors, and

the first node of each of the twelfth and the thirteenth MOS transistors is a source, the second node of each of the twelfth and the thirteenth transistors is a gate, and the third node of each of the twelfth and the thirteenth transistors is a drain.

15. The method of claim 9, wherein the first, the second, the fifth, the sixth, the seventh, the eighth and the ninth MOS transistors are NMOS transistors, the third, the fourth, the tenth, and the eleventh MOS transistors are PMOS transistors; and

the first node of each of the transistors is a source, the second node of each of the transistors is a gate, and the third node of each of the transistors is a drain, the first power source comprises a ground, and the second power source comprises a positive power supply.

16. The method of claim 11, wherein the twelfth and the thirteenth MOS transistors include PMOS transistors, and the first node of each of the twelfth and the thirteenth MOS transistors include a source, the second node of each of the twelfth and the thirteenth transistors include a gate, and the third node of each of the twelfth and the thirteenth transistors include a drain.

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